**Innovision Product Failure Analysis Request Form**

**Issue Date:**

**长工微产品失效分析申请表**

|  |  |  |  |  |  |
| --- | --- | --- | --- | --- | --- |
| From | Innovision FAE | Contact(联系人): |  | Mobile(移动电话): |  |
| Distributor(经销商) | Company(公司名称): | Contact(联系人): | Mobile(移动电话): |
|  |  |  |

**Customer Information(客户信息)：**

|  |  |  |  |
| --- | --- | --- | --- |
| Company Name(公司名称): |  | Address(公司地址): |  |
| Contact（联系人）: |  | Branch(部门): |  |
| Tel.(联系电话): |  | E-mail(电子邮箱): |  |

Failure Sample Information(失效样品信息)：

|  |  |  |  |
| --- | --- | --- | --- |
| Product No.(产品型号): |  | Lot No. (批次号): |  |
| Date Code (生产日期): |  | Purchase Quantity (使用数量) |  |
| Quantity Failure(失效数量) |  | Quantity Returned(退回数量) |  |

**Failure Case Description(失效情况描述)：**

|  |  |  |
| --- | --- | --- |
| Failure Type(失效类型) | 1）Line Failure(产线失效，失效站点)： |  |
| 2）Field Failure(市场失效，客户和使用时间)： |  |
| 3）Experiment Failure(实验失效，实验条件)： |  |
| 4）Other(其他)： |  |
| Failure Time(失效发生时间): |  |
| Can the failure phenomenon recur? (失效现象能否复现？) |  |
| Failure Description（失效情况描述，比如应用条件，失效现象，芯片阻抗等） |  |
| Failure analysis requirements(失效分析诉求) |  |

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